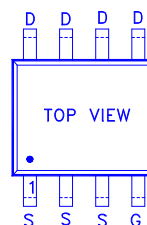
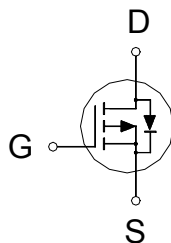


**PRODUCT SUMMARY**

$V_{(BR)DSS}$	$R_{DS(ON)}$	$I_D$
-30	10.5mΩ	-13A



4 :GATE  
5,6,7,8 :DRAIN  
1,2,3 :SOURCE

**ABSOLUTE MAXIMUM RATINGS ( $T_A = 25\text{ }^\circ\text{C}$  Unless Otherwise Noted)**

PARAMETERS/TEST CONDITIONS		SYMBOL	LIMITS	UNITS
Drain-Source Voltage		$V_{DS}$	-30	V
Gate-Source Voltage		$V_{GS}$	±25	V
Continuous Drain Current	$T_A = 25\text{ }^\circ\text{C}$	$I_D$	-13	A
	$T_A = 70\text{ }^\circ\text{C}$		-9	
Pulsed Drain Current <sup>1</sup>		$I_{DM}$	-50	
Avalanche Current		$I_{AS}$	-49	A
Avalanche Energy	$L = 0.1\text{mH}$	$E_{AS}$	120	mJ
Power Dissipation	$T_A = 25\text{ }^\circ\text{C}$	$P_D$	2.5	W
	$T_A = 70\text{ }^\circ\text{C}$		1.6	
Operating Junction & Storage Temperature Range		$T_j, T_{stg}$	-55 to 150	°C

**THERMAL RESISTANCE RATINGS**

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Case	$R_{\theta JC}$		25	°C / W
Junction-to-Ambient	$R_{\theta JA}$		50	°C / W

<sup>1</sup>Pulse width limited by maximum junction temperature.

**ELECTRICAL CHARACTERISTICS ( $T_A = 25\text{ }^\circ\text{C}$ , Unless Otherwise Noted)**

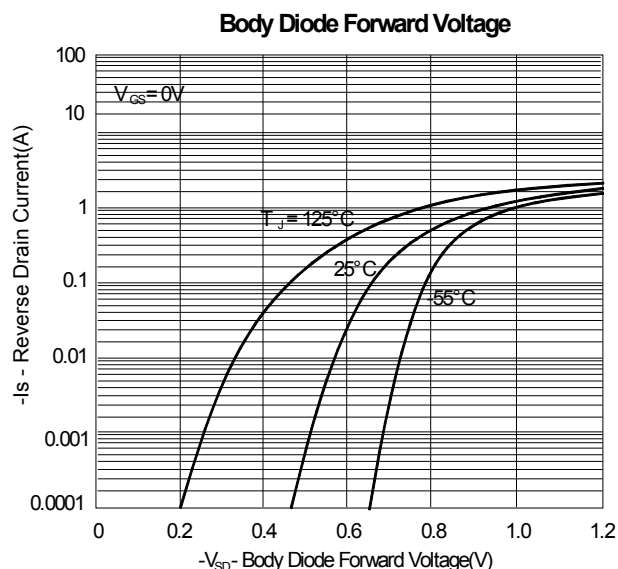
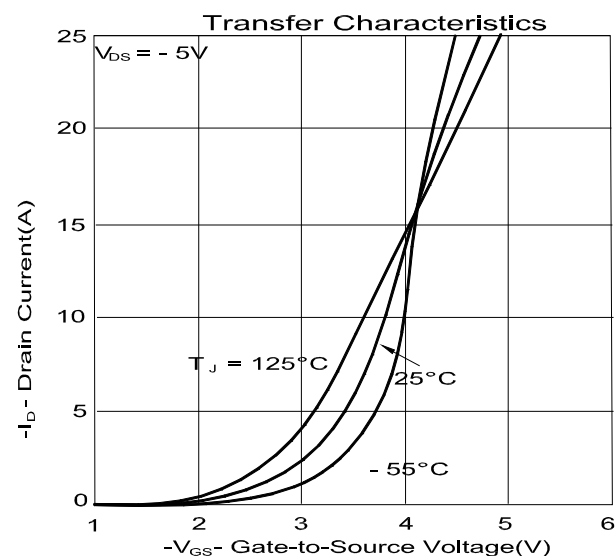
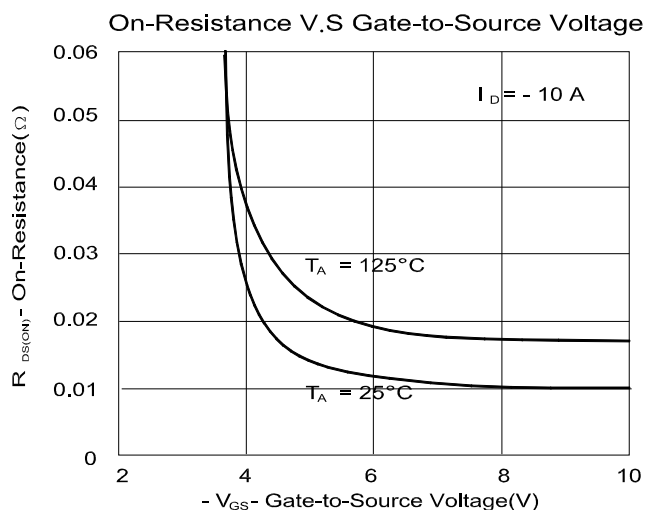
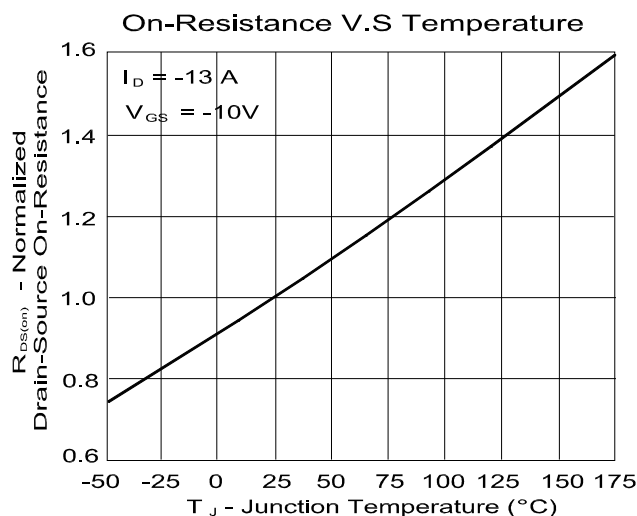
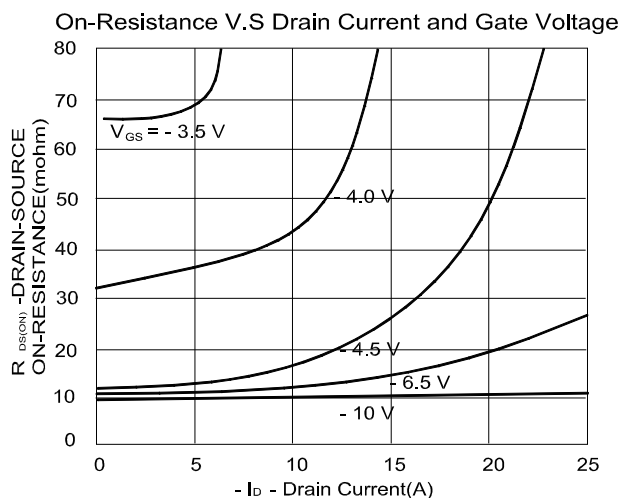
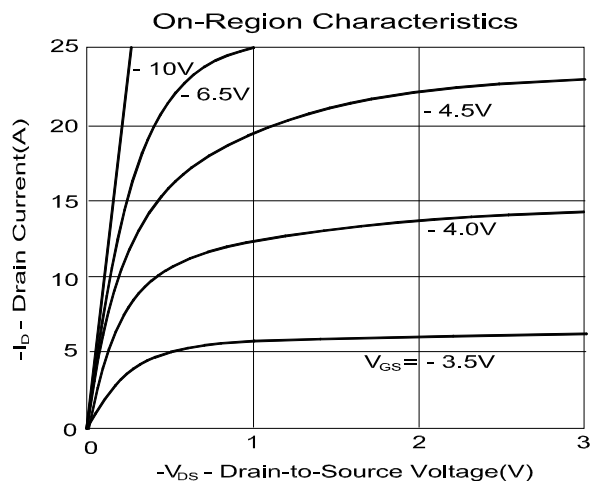
PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
<b>STATIC</b>						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = -250\mu A$	-30			V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = -250\mu A$	-1	-1.5	-3	
Gate-Body Leakage	$I_{GSS}$	$V_{DS} = 0V, V_{GS} = \pm 25V$			±100	nA
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = -24V, V_{GS} = 0V$			-1	μA
		$V_{DS} = -20V, V_{GS} = 0V, T_J = 125\text{ }^\circ\text{C}$			-10	
On-State Drain Current <sup>1</sup>	$I_{D(ON)}$	$V_{DS} = -5V, V_{GS} = -10V$	-50			A

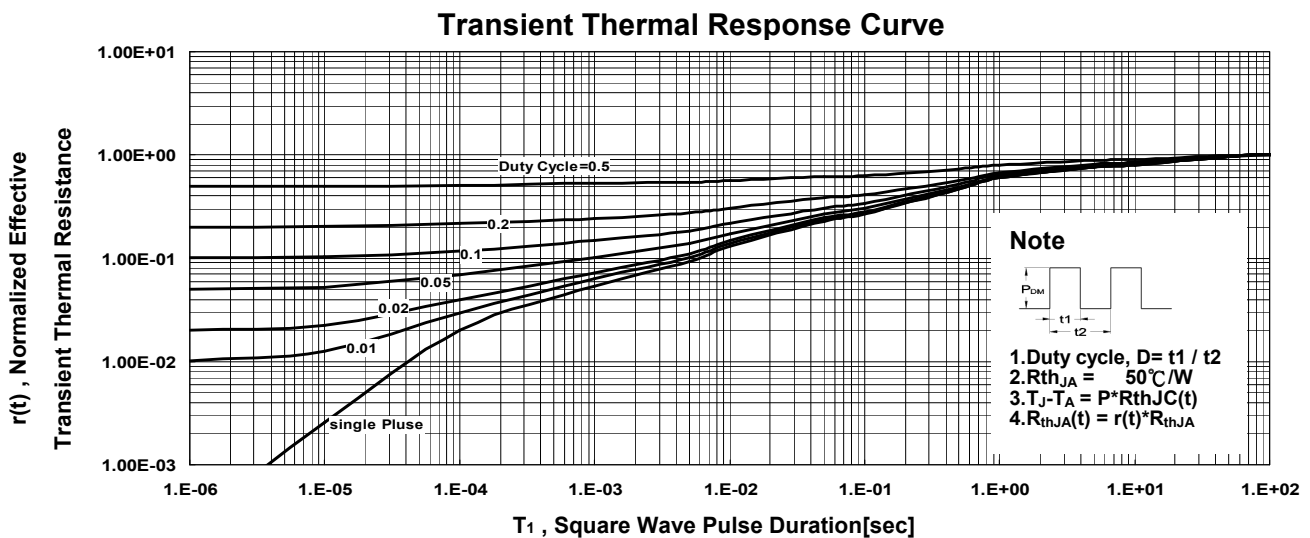
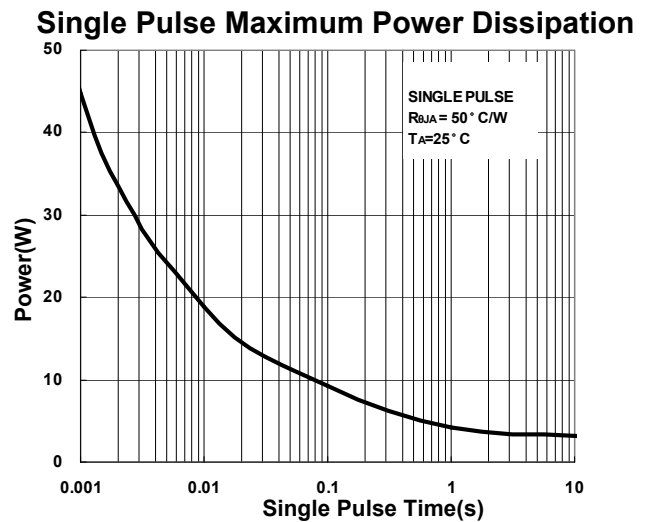
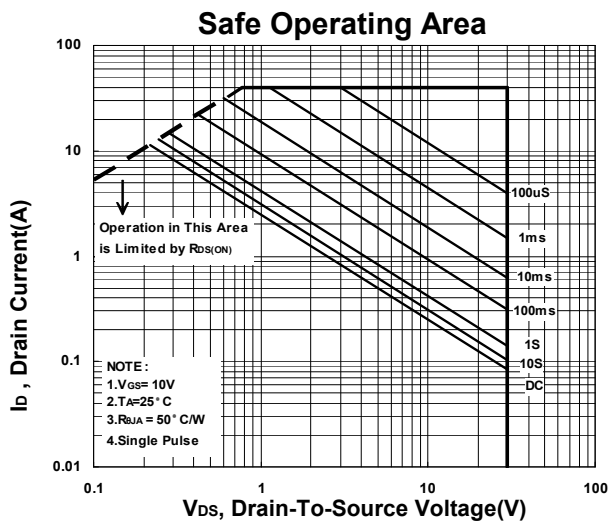
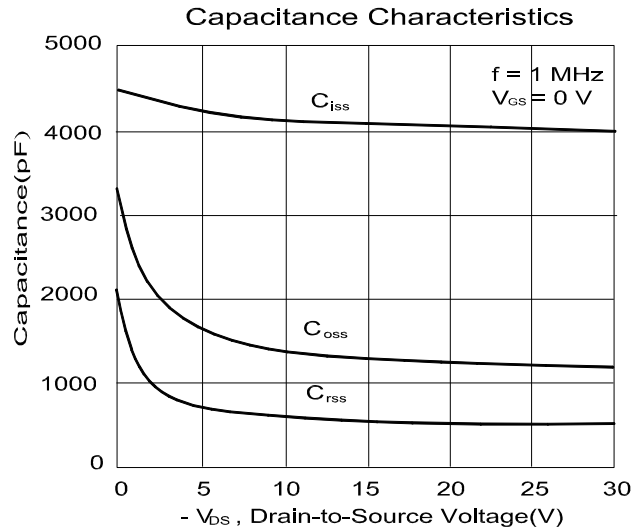
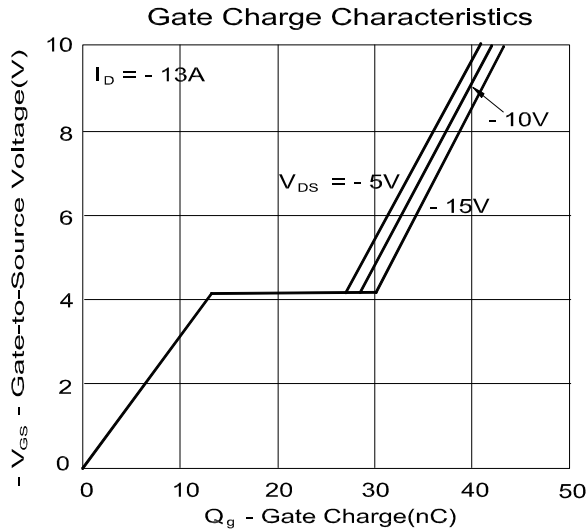
Drain-Source On-State Resistance <sup>1</sup>	R <sub>DS(ON)</sub>	V <sub>GS</sub> = -4.5V, I <sub>D</sub> = -10A		13	16	mΩ
		V <sub>GS</sub> = -6.5V, I <sub>D</sub> = -13A		10.5	12	
		V <sub>GS</sub> = -10V, I <sub>D</sub> = -13A		9	10.5	
Forward Transconductance <sup>1</sup>	g <sub>fs</sub>	V <sub>DS</sub> = -10V, I <sub>D</sub> = -13A		29		S
<b>DYNAMIC</b>						
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0V, V <sub>DS</sub> = -15V, f = 1MHz		4200		pF
Output Capacitance	C <sub>oss</sub>			1218		
Reverse Transfer Capacitance	C <sub>rss</sub>			504		
Total Gate Charge <sup>2</sup>	Q <sub>g</sub>	V <sub>DS</sub> = 0.5V <sub>(BR)DSS</sub> , V <sub>GS</sub> = -10V, I <sub>D</sub> = -13A		42		nC
Gate-Source Charge <sup>2</sup>	Q <sub>gs</sub>			12.6		
Gate-Drain Charge <sup>2</sup>	Q <sub>gd</sub>			15.4		
Turn-On Delay Time <sup>2</sup>	t <sub>d(on)</sub>	V <sub>DS</sub> = -15V, I <sub>D</sub> ≅ -1A, V <sub>GS</sub> = -10V, R <sub>GS</sub> = 6Ω		16.8		nS
Rise Time <sup>2</sup>	t <sub>r</sub>			22.4		
Turn-Off Delay Time <sup>2</sup>	t <sub>d(off)</sub>			70		
Fall Time <sup>2</sup>	t <sub>f</sub>			140		
<b>SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (T<sub>A</sub> = 25 °C)</b>						
Continuous Current	I <sub>S</sub>				-2.1	A
Forward Voltage <sup>1</sup>	V <sub>SD</sub>	I <sub>F</sub> = I <sub>S</sub> , V <sub>GS</sub> = 0V			-1.2	V

<sup>1</sup>Pulse test : Pulse Width ≤ 300 μsec, Duty Cycle ≤ 2%.

<sup>2</sup>Independent of operating temperature.

**REMARK: THE PRODUCT MARKED WITH “P1003EVG”, DATE CODE or LOT #**





**SOP-8 MECHANICAL DATA**

Dimension	mm			Dimension	mm		
	Min.	Typ.	Max.		Min.	Typ.	Max.
A	4.70	4.90	5.10	H	0.40	0.715	0.83
B	3.70	3.90	4.10	I	0.19	0.22	0.26
C	5.80	6.00	6.20	J	0.25	0.375	0.5
D	0.33	0.445	0.51	K	0°	4°	8°
E		1.27		L			
F	1.20	1.375	1.62	M			
G	0.08	0.175	0.28	N			

